# Notice of References Cited

Application/Control No. 10/797,650	Applicant(s)/P Reexaminatio TOMITA, AKI	
Examiner	Art Unit	
Thanh D. Vo	2189	Page 1 of 3

#### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0097524 A1	05-2003	Brant et al.	711/114
*	В	US-2003/0131068 A1	07-2003	Hoshino et al.	709/216
*	С	US-2003/0182348 A1	09-2003	Leong et al.	709/100
*	D	US-2003/0182503 A1	09-2003	Leong et al.	711/114
*	ш	US-2004/0030852 A1	02-2004	Coombs et al.	711/162
*	F	US-2004/0098547 A1	05-2004	Ofek et al.	711/162
*	G	US-2004/0128442 A1	07-2004	Hinshaw et al.	711/114
*	Ξ	US-2004/0168034 A1	08-2004	Homma et al.	711/162
*	_	US-2004/0230859 A1	11-2004	Cochran et al.	714/002
*	J	US-2005/0034013 A1	02-2005	Yamamoto et al.	714/006
*	K	US-2005/0071710 A1	03-2005	Micka et al.	714/006
*	L	US-2005/0071586 A1	03-2005	Bartfai et al.	711/162
*	М	US-2005/0071708 A1	03-2005	Bartfai et al.	714/005

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	Z					
	0					
	Ρ					
	α					
	R					
	S					
	Т					

#### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	v	
	w	*
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

# Notice of References Cited

Application/Control No. 10/797,650	Applicant(s)/Patent Under Reexamination TOMITA, AKI Art Unit		
Examiner			
Thanh D. Vo	2189	Page 2 of 3	

# U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,889,935 A	03-1999	Ofek et al.	714/6
*	В	US-6,044,444 A	03-2000	Ofek, Yuval	711/162
*	С	US-6,173,377 B1	01-2001	Yanai et al.	711/162
*	D	US-6,199,074 B1	03-2001	Kern et al.	707/204
*	E	US-2002/0059505 A1	05-2002	St. Pierre et al.	711/162
*	F	US-2002/0144068 A1	10-2002	Ohran, Richard S.	711/161
*	O	US-2002/0181415 A1	12-2002	West et al.	370/312
*	Ι	US-2003/0051111 A1	03-2003	Nakano et al.	711/162
*	-	US-2003/0126327 A1	07-2003	Pesola et al.	710/74
*	7	US-2003/0225966 A1	12-2003	Frandsen, Jorgen	711/111
*	К	US-2005/0021573 A1	01-2005	McDermott et al.	707/204
*	٦	US-2005/0108302 A1	05-2005	Rand et al.	707/204
*	М	US-2005/0154846 A1	07-2005	Chen et al.	711/162

### **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

#### Applicant(s)/Patent Under Reexamination 10/797,650 TOMITA, AKI Notice of References Cited Art Unit Examiner Page 3 of 3 Thanh D. Vo 2189

Application/Control No.

### **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2002/0046330 A1	04-2002	Suzuki et al.	711/162
*	В	US-2002/0129047 A1	09-2002	Cane et al.	707/204
*	С	US-6,820,180 B2	11-2004	McBrearty et al.	711/162
	D	US-			
	E.	US-			
	F	US-			
	G	US-		100.00	
	Н	US-			
	ı	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
	R					
	s					
	Т					

#### **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	٧	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.